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Accredited EMC-Test-Laboratory

DAR-No.: TTI-P-G-166/98-30

Listed by

FEDERAL COMMUNICATIONS COMMISSION (FCC)
Registration Number: 90462
FCC Website: WWW.FCC.GOV

Test report no.: 4-0541a-1-1/02

Type identification: W-LAN card 'PA3171U-1MPC' in

TOSHIBA Notebook 'Portege 2000'

FCC id: CJ6PA3171WL



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1 General Information

1.1 Notes

The test results of this test report relate exclusively to the test item specified in 1.6. The CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalisations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of the CETECOM ICT Services GmbH.

1.2 Statement of Compliance

The SAR values found for the TOSHIBA laptop 'Portege 2000' with WLAN card 'PA3171U-1MPC' are below the maximum recommended levels of 1.6 W/Kg as averaged over any 1 g tissue according the FCC rule §2.1093, the ANSI/IEEE C 95.1:1999 and the NCRP Report Number 86 for uncontrolled environment.

Carlo

Tester operator:

2002-02-05 Fabien Coulet

Date Name Signature

Technical responsibility for area of testing:

2002-02-05 Bernd Rebmann

Date Name Signature



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1.3 Testing laboratory

CETECOM ICT Services GmbH

Untertürkheimer Straße 6-10, D-66117 Saarbrücken

Germany

Telephone: +49 681 598 - 0
Fax: +49 681 598 - 8475
e-mail: info@ict.cetecom.de
Internet: http://www.cetecom.com

State of accreditation: The Test laboratory SAR is accredited according to DIN EN ISO / IEC

17025 45001.

DAR-No.:TTI-P-G-166/98-30

Test location, if different from CETECOM ICT Services GmbH

Name: --Street: --Town: --Country: --Phone: --Fax: ---

1.4 Details of applicant

Name: TOSHIBA Corporation Digital Media Network Company

Ome Operations-Digital Media Equipment

Street: 2-9, SUEHIRO-CHO, OME

Town: TOKYO, 198-8710

Country: Japan

Contact: Mr. KOICHI KAJI

Phone: +81-428-30-7432

Fax: +81-428-34-1445

1.5 Application details

Date of receipt of application: 2002-02-04

Date of receipt of test item: 2002-02-04

Date of test: 2002-02-04

Person who have been present during the test: ---



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1.6 Test item

Description of test item:

EUT Type: Laptop with integrated miniPCI WLAN card

Trade Name: Toshiba
Model: Portege 2000

SW: --

Frequency: 2402-2483.5 MHz here 2412-2462 MHz Modulation: 22M0P7D (DSSS) ch steps: 5 MHz

Number of channels: 11

Max RF output power: 19.2 dBm cond.

Antenna Type: integral **notebook** antenna

Power supply: 15V DC

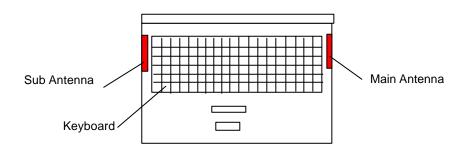
1.6.1 Antenna data

Model Name: HTL-007-P***
Frequency Range: 2.4 – 2.5 GHz

Bandwidth: Over 200MHz (VSWR :under 2)

Gain (Average): Antenna fixed beside of keyboard of Portege2000

Antenna	X-Y PLANE ((dBi)	Y-Z PLANE (dBi)		
	Horizontal	Vertical	Horizontal	Vertical	
Wireless LAN Main	-7.8	-3.9	-0.0	-2.9	
Wireless LAN Sub	-14.0	-7.5	-13.4	-5.1	





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1.7 Test specifications

Supplement C (Edition 01-01) to OET Bulletin 65 (Edition 97-01)

Draft IEEE Std 1528-200X: Version 6.4:July 2001

1.7.1 RF exposure limits

Human Exposure	Uncontrolled Environment General Population	Controlled Environment Occupational
Spatial Peak SAR* (Brain)	1.60 mW/g	8.00 mW/g
Spatial Average SAR** (Whole Body)	0.08 mW/g	0.40 mW/g
Spatial Peak SAR*** (Hands/Feet/Ankle/Wrist)	4.00 mW/g	20.00 mW/g

Table 1: RF exposure limits

Notes:

- * The Spatial Peak value of the SAR averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time
- ** The Spatial Average value of the SAR averaged over the whole body.
- *** The Spatial Peak value of the SAR averaged over any 10 grams of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure.

Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e. as a result of employment or occupation).



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2 Technical test

2.1. Summary of test results

No deviations from the technical specification(s) were ascertained in the course of the tests performed.
The deviations as specified in 2.4 were ascertained in the course of the tests performed.

2.2 Test environment

Ambient temperature: 21°C – 23°C

Tissue simulating liquid: $21^{\circ}C - 23^{\circ}C$

2.3 Test equipment used

Manufacturer	Device	Туре	Serial number	Date of last calibration
Schmid & Partner	Dosimetric E-Fiel	ET3DV6	1558	February 20, 2001
Engineering AG	Probe			
Schmid & Partner	Dosimetric E-Fiel	ET3DV6	1559	February 20, 2001
Engineering AG	Probe			
Schmid & Partner	900 MHz System	D900V2	102	February 13, 2001
Engineering AG	Validation Dipole			
Schmid & Partner	1800 MHz System	D1800V2	287	February 13, 2001
Engineering AG	Validation Dipol			
Schmid & Partner	Data acquisition	DAE3V1	413	January 15, 2001
Engineering AG	electronics			
Schmid & Partner	Software	DASY 3 V3.1c		Calibration isn't
Engineering AG				necessary
Schmid & Partner	Phantom	Pre SAM		Calibration isn't
Engineering AG				necessary
Rohde & Schwarz	Universal Radio	CMU 200	U-972406/000	August 30, 2001
	Communication			
	Tester			
Hewlett Packard	Network Analyser	HP 8753C	2936A00872	Mai 11, 1998
	300 kHz to 3 GHz			
Agilent	Dielectric Probe Kit	Agilent 85070C	US99360146	March 8, 2001



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2.4 Test results (Body SAR)

The table contain the measured SAR values averaged over a mass of 1 g					
Frequency	Position	Touch on the flat phantom	Limit		
Ch 7 2442 MHz	Touch right (see photo 2)	0.985 W/kg	1.6 W/kg		
Ch 7 2442 MHz	Touch left (see photo 3)	0.0023 W/kg	1.6 W/kg		
Ch 7 2442 MHz	under –right side- (see photo 4)	0.0747 W/kg	1.6 W/kg		
Ch 7 2442 MHz	under –left side- (see photo 5)	0.0019 W/kg	1.6 W/kg		

Table 3: Test results (Body SAR)

Note 1: Upper and lower frequencies were not measured because the values at the middle frequency did not exceed 1.27 W/kg (1.60 W/kg reduced of 2 dB)

Note 2: The used conversion factor during the measurement was 5.56 at 1800MHz, this value was not extrapolated to a frequency of 2400 MHz since use of a conversion of 5.40 is the worst case condition. From the supplied calibration for the probe S/N1559, it can be seen that the ConvF is inversely related to frequency (see page 27), that means that when the frequency increases the ConvF decreases. Since the ConvF factor for the DASY system appears in the numerator, the calculated SAR value will decrease with lower ConvF factors.



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2.5 Tissue dielectric properties

The dielectric properties have been measured by the contact probe method at 22-24°C. The following materials are used for producing the tissue-equivalent materials:

Ingredients		Frequency (MHz)								
(% by weight)										
Used frequency		450		835		915	□ 1900		2 450	
Tissue Type	Head	Body	Head	Body	Head	Body	Head	Body	Head	Body
Water	38.56	51.16	41.45	52.4	41.05	56.0	54.9	70.0	62.7	73.2
Salt (NaCl)	3.95	1.49	1.45	1.40	1.35	0.76	0.18	0.3	0.5	0.04
Sugar	56.32	46.78	56.0	45.0	56.5	41.76	0.0	0.0	0.0	0.0
HEC	0.98	0.52	1.0	1.0	1.0	1.21	0.0	0.0	0.0	0.0
Bactericide	0.19	0.05	0.1	0.1	0.1	0.27	0.0	0.0	0.0	0.0
Triton X-100	0.0	0.0	0.0	0.0	0.0	0.0	0.0	0.0	36.8	0.0
DGBE	0.0	0.0	0.0	0.0	0.0	0.0	44.92	29.7	0.0	26.7

Table 4: Tissue dielectric properties

Salt: 99+% Pure Sodium Chloride Sugar: 98+% Pure Sucrose Water: De-ionized, $16M\Omega$ + resistivity HEC: Hydroxyethyl Cellulose

DGBE: 99+% Di(ethylene glycol) butyl ether, [2-(2-butoxyethoxy)ethanol]

Triton X-100 (ultra pure): Polyethylene glycol mono [4-(1,1,3,3-tetramethylbutyl)phenyl]ether

2.6 Tissue parameters

Used Target Frequency		rget Tissue	Target Body Tissue		Measured Head Tissue		Measured Body Tissue		Measured Date
[MHz]	\mathcal{E}_{r}	σ [S/m]	\mathcal{E}_{r}	σ[S/m]	\mathcal{E}_{r}	σ[S/m]	\mathcal{E}_{r}	σ[S/m]	
☐ 450	43.5	0.87	56.7	0.94	-		-		
□ 835	41.5	0.90	55.2	0.97					
900	41.5	0.97	55.0	1.05					
915	41.5	0.98	55.0	1.06					
■ 1800 - 2000	40.0	1.40	53.3	1.52					
× 2450	39.2	1.80	52.7	1.95			52.4	2.05	4 th February 02

Table 5: Parameter of the tissue simulating liquid



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2.7 Measurement uncertainties

The overall combined measurement uncertainty of the measurement system is $\pm 12,1\%$ (K=1). The breakdown of the individual uncertainties is as follows:

		Calibration Erro	r :				
	Probability Distribution		Stand	ard Uncertain	ity		
	21301100001	900 MHz	1500) MHz	180	0 MHz	
Incident power	Rectangular	± 1,2 %	± 1,2		± 1.	,2 %	
Mismatch uncertainty	Rectangular	± 0,6 %	± 0,0	5 %	± 0.	6 %	
Exp. fitting error (95% confidence)	Normal	± 0,4 %	± 0,2	2 %	± 0.	2 %	
Liquid permittivity	Rectangular	± 2,3 %	± 2,3	8 %	± 2,	9 %	
Probe positioning	Normal	± 0,5 %	± 0,3	8 %	± 1.	0 %	
Field homogeneity	Rectangular	± 0,6 %	± 1,2	2 %	± 1.	4 %	
Combined Standard Uncerta	ninty	± 2,8 %	± 3,	4 %	± 3	,6 %	
	E	-Field Probe Err	nr•				
Error Description	Error	Probability Dis		Weight		Standard Incertainty	
Isotropy around axis	± 0,2 dB	U-shape		0,5	± 2,4		
Spherical Isotropy	± 0,4 dB	U-shape		0,5	± 4,8		
Isotropy from gradient	± 0,5 dB	U-shape	0		1 - 1,5 / 2		
Spatial resolution	± 0,5 %	normal	1		± 0,5 %		
Linearity error	± 0,2 dB	rectangular		1		%	
Calibration error	± 3,6 %	normal				,6 %	
Combined Standard Uncerta		•		± 6,9			
	•	ource Uncertain	tv•		. /		
Error Description	Error	Probability Distr	•	Weight	Stand	lard rtainty	
Device positioning	± 6%	normal		1		_	
Laboratory set-up	±3 %	normal		1			
Combined Standard Uncerta	ninty:				± 6,7	%	
	SA	R Evaluation E	rror				
Error Description	Error	Probability Distribution	Weight	Standa Uncerta		Offset	
Data acquisition error	± 1%	rectangular	1	± 0,6 %			
ELF and RF disturbances	± 0,25 %			± 0,25 %			
Conductivity assessment	± 10 %			$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			
Extrapolation and boundary effects	±3 %	normal	1			+ 5 %	
Probe positioning	± 0,1 mm	normal	1	±1%			
Integration and cube orientation	±3 %	normal	1 ±				
Cube shape inaccuracies	±2%	rectangular	1	± 1.2 %			
Combined Standard Uncerta				± 7,4 %			



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Combined Uncertainties					
Error Description	Standard Uncertainty	Offset			
E-field probe errors	± 6.9 %				
SAR evaluation error	± 7.4 %	± 5 %			
Source uncertainty	± 6,7 %				
Combined Standard Uncertainty:	± 12.1 %				
Expanded Uncertainty (k=2):	± 24,2 %				

Table 6: Measurement uncertainties

The measurement uncertainties were performed by Schmid & Partner Engineering AG.

2.8 System validation

The system validation is used for verifying the accuracy of the complete measurement system and performance of the software. The system validation is performed with 1800 MHz head tissue equivalent material according IEEE Std 1528-200X: 2001. (graphics plots attached).

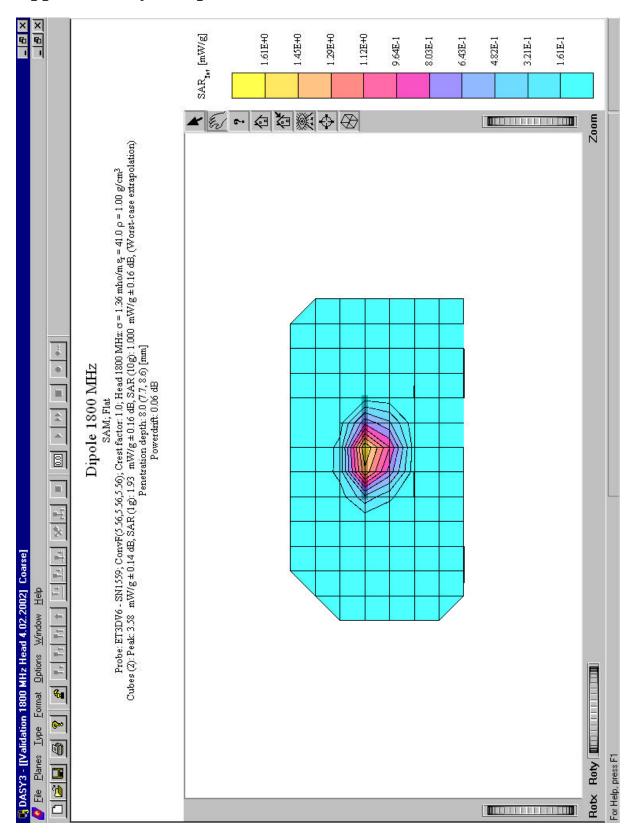
Validation Kit	Frequency	Target SAR _{1g}	Target SAR _{10g}	Measured SAR _{1g}	Measured SAR _{10g}	Measured date
D1800V2, S/N:287	1800 MHz	1.905 mW/g	0.99 mW/g	1.93 mW/g	1.00 mW/g	2002-02-04

Table 7: Test results (system validation)



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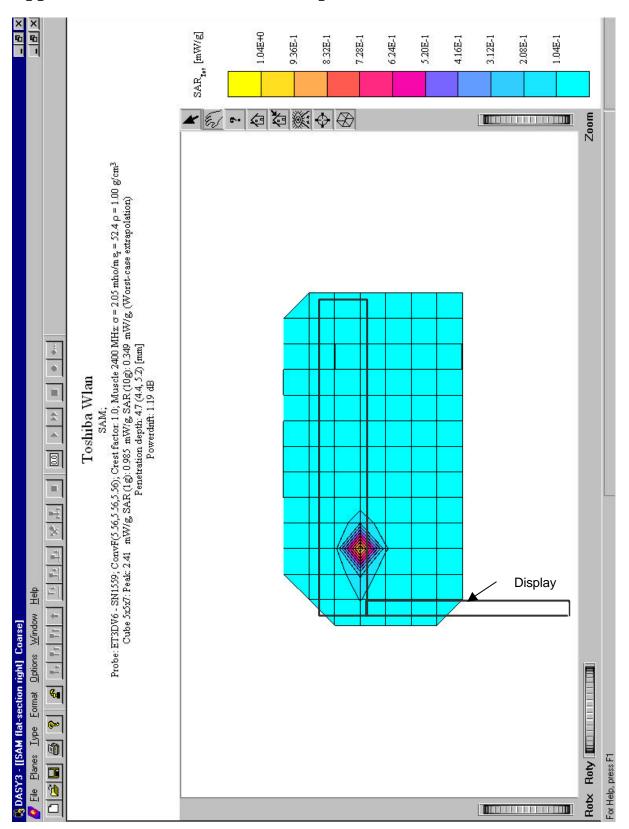
Appendix 1: System performance verification





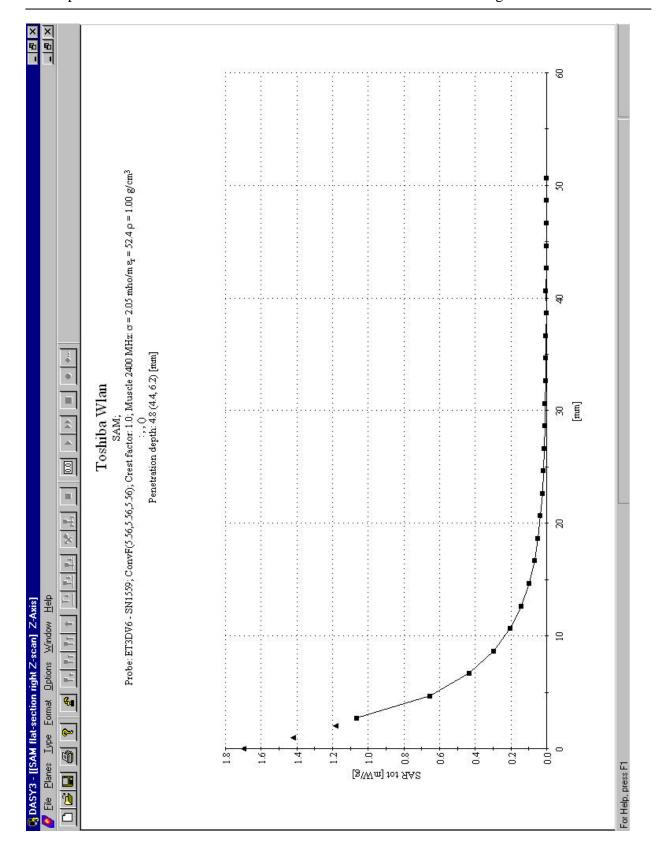
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Appendix 2: Measurement results (printout from DASY TM)



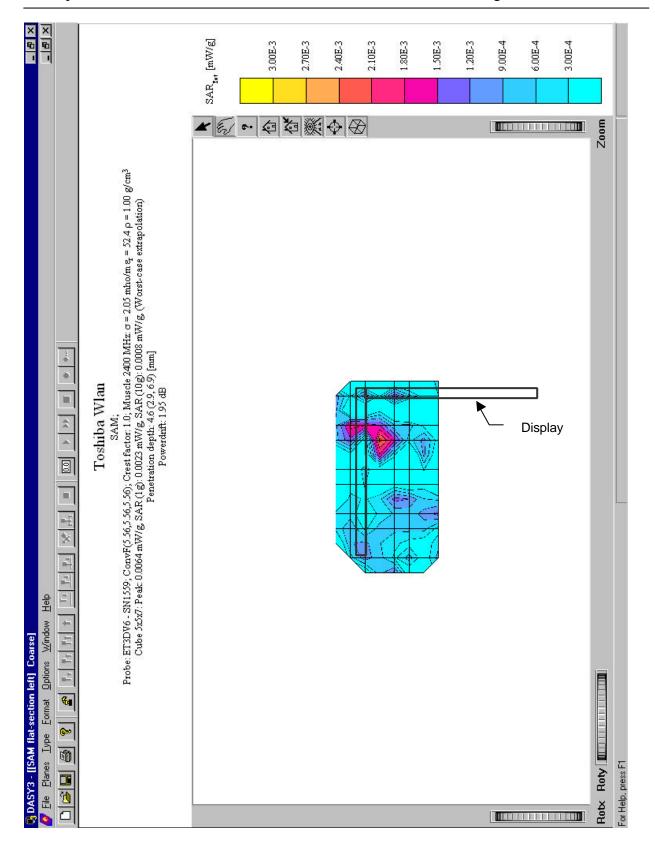


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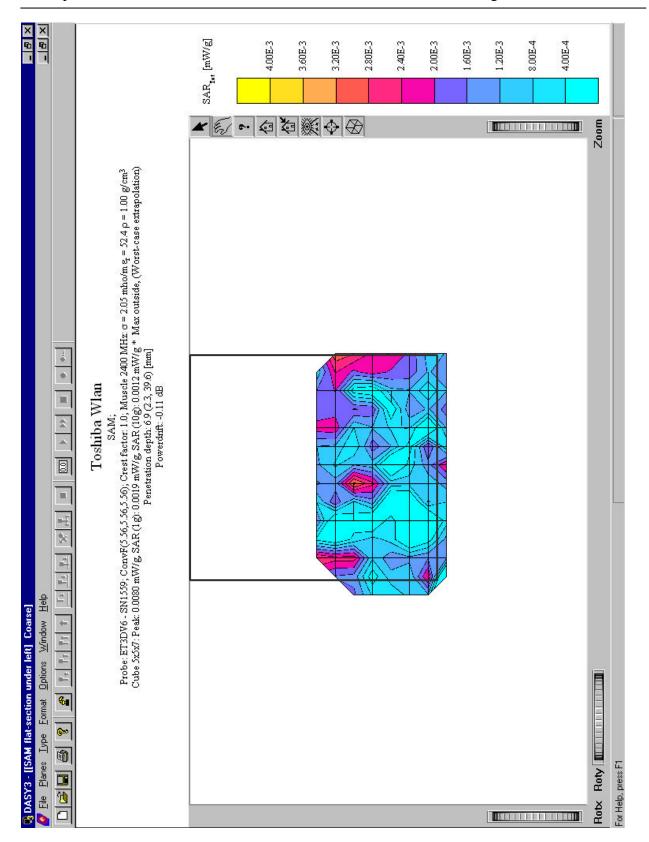


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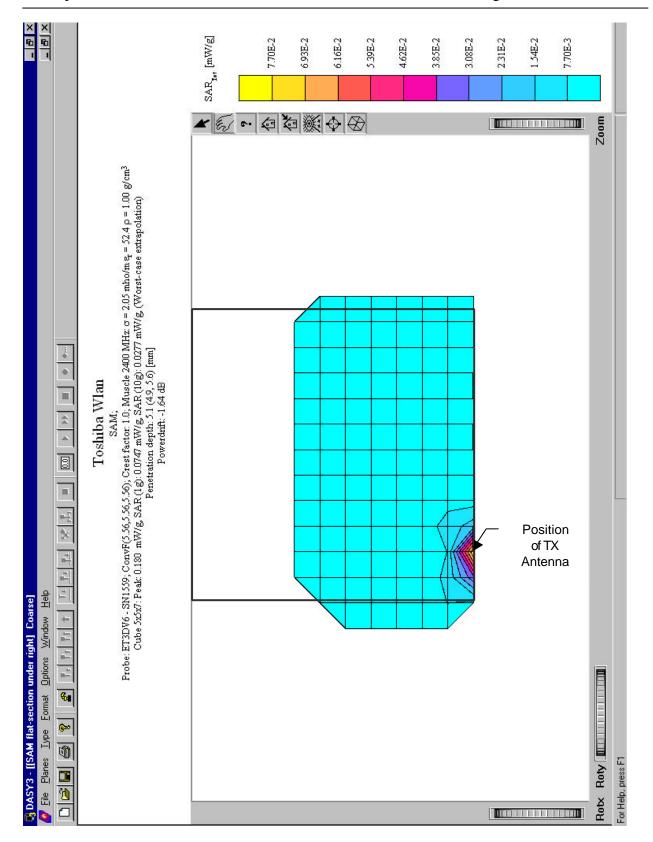


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Appendix 3: Photo documentation



Photo 1: Measurement System DASY 3



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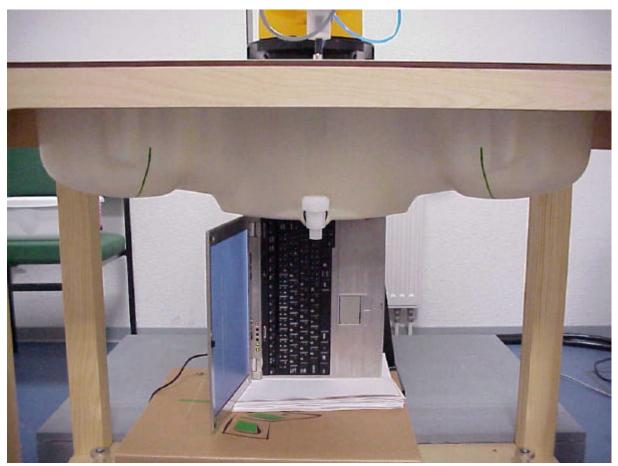


Photo 2: Touch position right side



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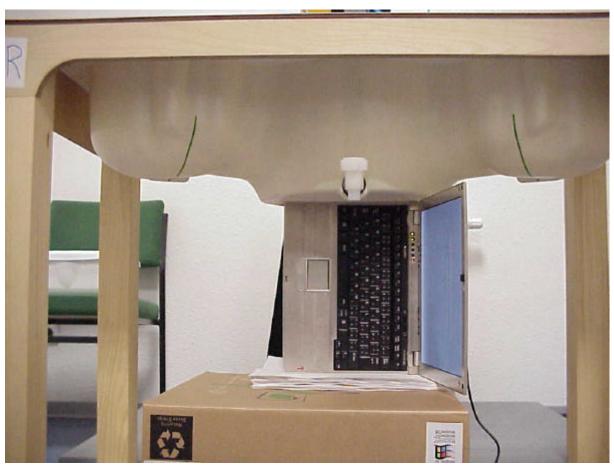


Photo 3: Touch position left side



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Photo 4: EUT under side (right position)



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Photo 5: EUT under side (left position)



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Photo 6: EUT



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Photo 7: EUT upper side



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Photo 8: EUT rear side



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Photo 8: EUT under side



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Appendix 4: Calibration parameters of E-field probe

Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland, Phone +41 1 245 97 00, Fax +41 1 245 97 79

Calibration Certificate

Dosimetric E-Field Probe

Type:	ET3DV6
Serial Number:	1559
Place of Calibration:	Zurich
Date of Calibration:	Feb. 20, 2001
Calibration Interval:	12 months

Schmid & Partner Engineering AG hereby certifies, that this device has been calibrated on the date indicated above. The calibration was performed in accordance with specifications and procedures of Schmid & Partner Engineering AG.

Wherever applicable, the standards used in the calibration process are traceable to international standards. In all other cases the standards of the Laboratory for EMF and Microwave Electronics at the Swiss Federal Institute of Technology (ETH) in Zurich, Switzerland have been applied.

Calibrated by:

Approved by:



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ET3DV6 SN:1559

DASY3 - Parameters of Probe: ET3DV6 SN:1559

Sensitivity in Free Space				Diode Compression		
	NormX	1.51	$\mu V/(V/m)^2$		DCP X	102 m√
	NormY	1.54	μ V/(V/m) ²		DCP Y	102 mV
	NormZ	1.51	μ V/(V/m) ²		DCP Z	102 m\
Sensiti	vity in Tissu	ue Simu	ulating Liquid			
Head	450 MHz		ε _r = 43.5 ± 5%	σ = 0.87 ± 10% mho/m		
	ConvF X	7.27	extrapolated		Boundary effe	ect:
	ConvF Y	7.27	extrapolated		Alpha	0.22
	ConvF Z	7.27	extrapolated		Depth	3.41
Head	900 MHz		$\epsilon_{\rm r}$ = 42 ± 5%	σ=	σ = 0.97 ± 10% mho/m	
	ConvF X	6.70	± 7% (k=2)		Boundary effe	ect:
	ConvF Y	6.70	± 7% (k=2)		Alpha	0.30
	ConvF Z	6.70	± 7% (k=2)		Depth	3.03
Head	1500 MHz		$\varepsilon_{\rm r}$ = 40.4 ± 5%	σ = 1.23 ± 10% mho/m		
	ConvF X	5.94	interpolated		Boundary effe	ect:
	ConvF Y	5.94	interpolated		Alpha	0.42
	ConvF Z	5.94	interpolated		Depth	2.53
Head	1800 MHz		$\varepsilon_{\rm r}$ = 40 ± 5%	σ=	σ = 1.40 ± 10% mho/m	
	ConvF X	5.56	± 7% (k=2)		Boundary effe	ect:
	ConvF Y	5.56	± 7% (k=2)		Alpha	0.48
	ConvF Z	5.56	± 7% (k=2)		Depth	2.27
Senso	r Offset					
	Probe Tip to Sensor Center			2.7	mm	
	Optical Surface Detection			2.3 ± 0.2	m	m